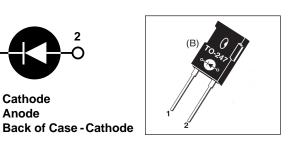


1 - Cathode 2 - Anode





ULTRAFAST SOFT RECOVERY RECTIFIER DIODE

PRODUCT APPLICATIONS	PRODUCT FEATURES	PRODUCT BENEFITS
 Anti-Parallel Diode -Switchmode Power Supply 	• Ultrafast Recovery Times	• Low Losses
-Inverters	 Soft Recovery Characteristics 	 Low Noise Switching
 Free Wheeling Diode -Motor Controllers 	• Popular T-MAX™	Cooler Operation
-Converters • Snubber Diode	 Low Forward Voltage 	 Higher Reliability Systems
Uninterruptible Power Supply (UPS)	 High Blocking Voltage 	• Increased System Power
Uninterruptible Power Supply (UPS)Induction HeatingHigh Speed Rectifiers	• Low Leakage Current	Density

MAXIMUM RATINGS

All Ratings: $T_C = 25^{\circ}C$ unless otherwise specified.

Symbol	Characteristic / Test Conditions	APT100D60BG	UNIT
V_R	Maximum D.C. Reverse Voltage		
V _{RRM}	Maximum Peak Repetitive Reverse Voltage	600	Volts
V _{RWM}	Maximum Working Peak Reverse Voltage		
I _F (AV)	Maximum Average Forward Current (T _C = 80°C, Duty Cycle = 0.5) (1)	100	
I _F (RMS)	RMS Forward Current	180	Amps
I _{FSM}	Non-Repetitive Forward Surge Current (T _J = 45°C, 8.3ms)	1000	
T _J ,T _{STG}	Operating and StorageTemperature Range	-55 to 150	
T _L	Lead Temperature: 0.063" from Case for 10 Sec.	300	°C

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions		MIN	TYP	MAX	UNIT
		I _F = 100A			2.0	
V_{F}	Maximum Forward Voltage	I _F = 200A		1.7		Volts
		I _F = 100A, T _J = 150°C			1.7	
	Maximum Reverse Leakage Current	$V_R = V_R$ Rated			250	
^I RM		$V_R = V_R \text{ Rated, } T_J = 125^{\circ}\text{C}$			500	μΑ
C _T	Junction Capacitance, V _R = 200V			165		pF
L _S	Series Inductance (Lead to Lead 5mm from Base)			20		nΗ

DYNAMIC CHARACTERISTICS

Symbol	Characteristic		MIN	TYP	MAX	UNIT
t _{rr1}	Reverse Recovery Time, $I_F = 1.0A$, $di_F/dt = -15A/\mu s$, $V_R = 30$	OV, T _J = 25°C		60	75	
t _{rr2}	Reverse Recovery Time	T _J = 25°C		60		
t _{rr3}	$I_F = 100A$, $di_F/dt = -800A/\mu s$, $V_R = 350V$	T _J = 100°C		92		ns
t _{fr1}	Forward Recovery Time	T _J = 25°C		185		
t _{fr2}	$I_F = 100A$, $di_F/dt = 800A/\mu s$, $V_R = 350V$	T _J = 100°C		185		
I _{RRM1}	Reverse Recovery Current	T _J = 25°C		27	38	A mno
I _{RRM2}	$I_F = 100A$, $di_F/dt = -800A/\mu s$, $V_R = 350V$	T _J = 100°C		42	54	Amps
Q _{rr1}	Recovery Charge	T _J = 25°C		810		nC
Q _{rr2}	$I_F = 100A$, $di_F/dt = -800A/\mu s$, $V_R = 350V$	T _J = 100°C		1930		IIC
V _{fr1}	Forward Recovery Voltage	T _J = 25°C		10.2		Volts
V _{fr2}	$I_F = 100A$, $di_F/dt = 800A/\mu s$, $V_R = 350V$	T _J = 100°C		10.2		VOILS
d:N1/d+	Rate of Fall of Recovery Current	T _J = 25°C		600		Λ/μο
diM/dt	$I_F = 100A$, $di_F/dt = -800A/\mu s$, $V_R = 350V$ (See Figure 10)	T _J = 100°C	_	400	_	A/µs

THERMAL AND MECHANICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-Case Thermal Resistance			0.34	°C/W
R_{\thetaJA}	Junction-to-Ambient Thermal Resistance			40	-C/vv
Wt Package Weight	Dodlova Weinki		0.22		oz
	Package weight		6.2		g

¹ Continuous current limited by lead temperature.

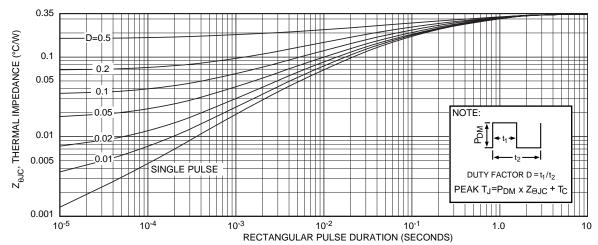
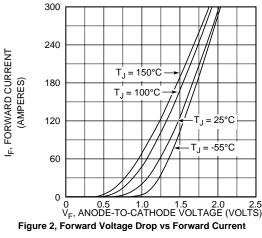


FIGURE 1, MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs PULSE DURATION

APT100D60BG



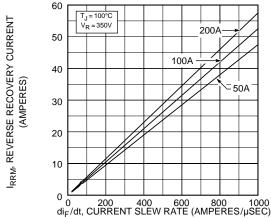


Figure 4, Reverse Recovery Current vs Current Slew Rate

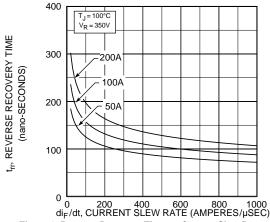


Figure 6, Reverse Recovery Time vs Current Slew Rate

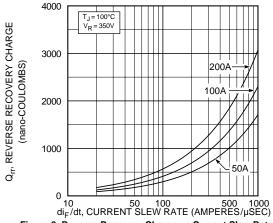


Figure 3, Reverse Recovery Charge vs Current Slew Rate

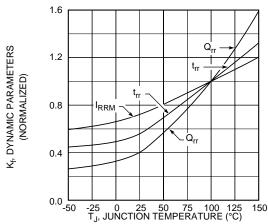


Figure 5, Dynamic Parameters vs Junction Temperature

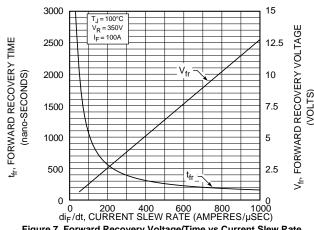


Figure 7, Forward Recovery Voltage/Time vs Current Slew Rate

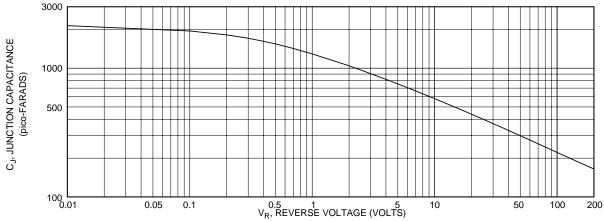


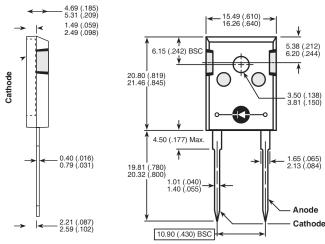
Figure 8, Junction Capacitance vs Reverse Voltage

Figure 9, Diode Reverse Recovery Test Circuit and Waveforms

1 I_F - Forward Conduction Current
2 di_F/dt - Current Slew Rate, Rate of Forward Current Change Through Zero Crossing.
3 I_{RRM} - Peak Reverse Recovery Current.
4 t_{rr} - Reverse Recovery Time Measured from Point of I_F Current Falling Through Zero to a Tangent Line { 6 diM/dt} Extrapolated Through Zero Defined by 0.75 and 0.50 I_{RRM}.
5 Q_{rr} - Area Under the Curve Defined by I_{RRM} and t_{rr}.
6 diM/dt - Maximum Rate of Current Change During the Trailing Portion of t_{rr}

Figure 10, Diode Reverse Recovery Waveform and Definitions

TO-247 Package Outline



Dimensions in Millimeters and (Inches)

Microsemi makes no warranty, representation, or guarantee regarding the information contained herein or the suitability of its products and services for any particular purpose, nor does Microsemi assume any liability whatsoever arising out of the application or use of any product or circuit. The products sold by Microsemi have been subject to limited testing and should not be used in conjunction with mission-critical equipment or applications. Any performance specifications are believed to be reliable but are not verified, and Buyer must conduct and complete all performance and other testing of the products, alone and together with, or installed in, any end-products. Buyer shall not rely on any data and performance specifications or parameters provided by Microsemi. It is the Buyer's responsibility to independently determine suitability of any products and to test and verify the same. The information provided by Microsemi hereunder is provided "as is, where is" and with all faults, and the entire risk associated with such information is entirely with the Buyer. Microsemi does not grant, explicitly or implicitly, to any party any patent rights, licenses, or any other IP rights, whether with regard to such information itself or anything described by such information. Information provided in this document is proprietary to Microsemi, and Microsemi reserves the right to make any changes to the information in this document or to any products and services at any time without notice.

Microsemi, a wholly owned subsidiary of Microchip Technology Inc. (Nasdaq: MCHP), offers a comprehensive portfolio of semiconductor and system solutions for aerospace & defense, communications, data center and industrial markets. Products include high-performance and radiation-hardened analog mixed-signal integrated circuits, FPGAs, SoCs and ASICs; power management products; timing and synchronization devices and precise time solutions, setting the world's standard for time; voice processing devices; RF solutions; discrete components; enterprise storage and communication solutions; security technologies and scalable anti-tamper products; Ethernet solutions; Power-over-Ethernet ICs and midspans; as well as custom design capabilities and services. Microsemi is headquartered in Aliso Viejo, California, and has approximately 4,800 employees globally. Learn more at www



Microsemi Headquarters

One Enterprise, Aliso Viejo,
CA 92656 USA
Within the USA: +1 (800) 713-4113
Outside the USA: +1 (949) 380-6100
Sales: +1 (949) 380-6136
Fax: +1 (949) 215-4996
Email: sales.support@microsemi.com

© 2020 Microsemi. All rights reserved. Microsemi and the Microsemi logo are trademarks of Microsemi Corporation. All other trademarks and service marks are the property of their respective owners.